

March 2013

FDP045N10A_F102 / FDI045N10A_F102

N-Channel PowerTrench $^{\mbox{\scriptsize R}}$ MOSFET 100 V, 164 A, 4.5 m Ω

Features

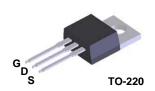
- $R_{DS(on)}$ = 3.8 m Ω (Typ.)@ V_{GS} = 10 V, I_D = 100 A
- · Fast Switching Speed
- Low Gate Charge, Q_G = 54 nC(Typ.)
- \bullet High Performance Trench Technology for Extremely Low $R_{\text{DS(on)}}$
- High Power and Current Handling Capability
- · RoHS Compliant

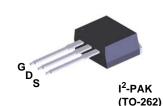
Description

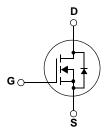
This N-Channel MOSFET is produced using Fairchild Semiconductor $^{\!8}$'s advance PowerTrench $^{\!8}$ process that has been tailored to minimize the on-state resistance while maintaining superior switching performance.

Applications

- Synchronous Rectification for ATX / Server / Telecom PSU
- Battery Protection Circuit
- Motor drives and Uninterruptible Power Supplies
- · Micro Solar Inverter







MOSFET Maximum Ratings T_C = 25°C unless otherwise noted

Symbol		FDP045N10A_F102 FDI045N10A_F102	Unit		
V _{DSS}	Drain to Source Voltage		100	V	
V _{GSS}	Gate to Source Voltage		±20	V	
		- Continuous (T _C = 25°C, Silicon Limited)			
I _D Drain Current		- Continuous (T _C = 100°C, Silicon LImited	116	Α	
		- Continuous (T _C = 25°C, Package Limited	120		
I _{DM}	Drain Current	- Pulsed (Note	1) 656	Α	
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		2) 637	mJ	
dv/dt	Peak Diode Recovery dv/dt	(Note	3) 6.0	V/ns	
D.	Device Discipation	$(T_C = 25^{\circ}C)$	263	W	
P _D Power Dissipation		- Derate above 25°C	1.75	W/°C	
T _J , T _{STG}	Operating and Storage Temp	perature Range	-55 to +175	οС	
T _L	Maximum Lead Temperature 1/8" from Case for 5 Second	for Soldering Purpose,	300	°C	

^{*}Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 120A.

Thermal Characteristics

Symbol	Parameter	FDP045N10A_F102 FDI045N10A_F102	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	0.57	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max. 62.5		*C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDP045N10A	FDP045N10A_F102	TO-220	-	-	50
FDI045N10A	FDI045N10A_F102	I2PAK	-	-	50

Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Charac	eteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	100	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C	-	0.07	-	V/°C
	Zero Gate Voltage Drain Current	$V_{DS} = 80V, V_{GS} = 0V$	-	-	1	^
IDSS	Zero Gate voltage Drain Current	$V_{DS} = 80V, T_C = 150^{\circ}C$	-	-	500	μА
I _{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	±100	nA

On Characteristics

V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	2.0	-	4.0	V
R _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 100A$	-	3.8	4.5	mΩ
9 _{FS}	Forward Transconductance	$V_{DS} = 10V, I_{D} = 100A$	-	132	-	S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 50V V 0V	-	3960	5270	pF
C _{oss}	Output Capacitance	$V_{DS} = 50V, V_{GS} = 0V$ f = 1MHz	-	925	1230	pF
C _{rss}	Reverse Transfer Capacitance	1 - 11/11/2	-	34	-	pF
C _{oss} (er)	Engry Releted Output Capacitance	$V_{DS} = 50V, V_{GS} = 0V$	-	1520	-	pF
Q _{g(tot)}	Total Gate Charge at 10V	V _{GS} = 10V, V _{DS} = 50V	-	54	74	nC
Q_{gs}	Gate to Source Gate Charge	I _D = 100A	-	17	-	nC
Q _{gs2}	Gate Charge Threshold to Plateau		-	8	-	nC
Q_{gd}	Gate to Drain "Miller" Charge	(Note 4)	-	13	-	nC

Switching Characteristics

t _{d(on)}	Turn-On Delay Time			-	23	56	ns
t _r	Turn-On Rise Time	$V_{DD} = 50V, I_{D} = 100A$			26	62	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10V, R_{GEN} = 4.7\Omega$		=	50	110	ns
t _f	Turn-Off Fall Time	(No	ote 4)	-	15	40	ns
ESR	Equivalent Series Resistance (G-S)	f = 1MHz		-	1.9	-	Ω

Drain-Source Diode Characteristics

I _S	Maximum Continuous Drain to Source Diode Forward Current			-	164*	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	656	Α
V_{SD}	Drain to Source Diode Forward Voltage	V _{GS} = 0V, I _{SD} = 100A	-	-	1.3	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, V _{DD} = 50V, I _{SD} = 100A	-	75	-	ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$	-	120	-	nC

- **Notes:**1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 3mH, I_{AS} = 20.6A, R_G = 25 Ω , Starting T_J = 25 $^{\circ}$ C
- 3. $I_{SD} \leq 100 A, \ di/dt \leq 200 A/\mu s, \ V_{DD} \leq BV_{DSS}, \ Starting \ T_J = 25^{\circ}C$
- 4. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

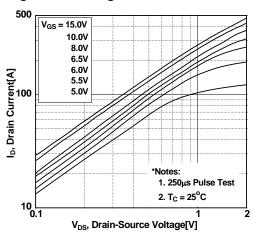


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

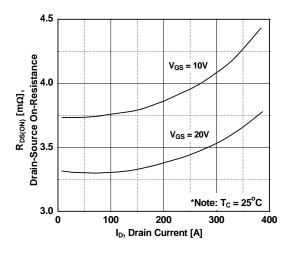


Figure 5. Capacitance Characteristics

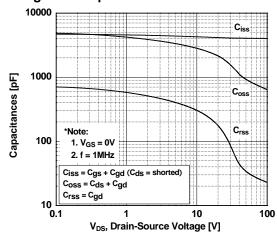


Figure 2. Transfer Characteristics

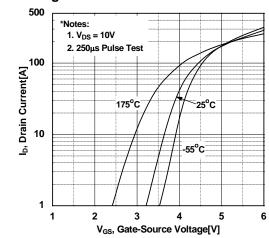


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

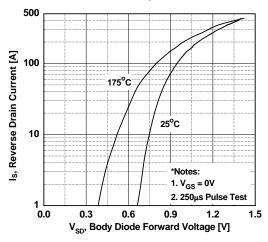
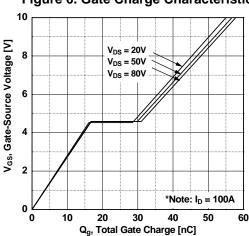


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

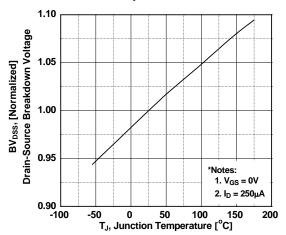


Figure 9. Maximum Safe Operating Area vs. Case Temperature

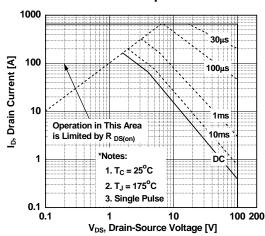


Figure 11. Eoss vs. Drain to Sourece Voltage

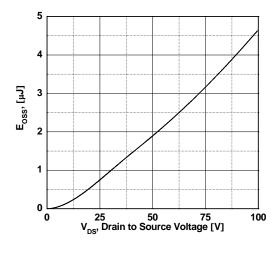


Figure 8. On-Resistance Variation vs. Temperature

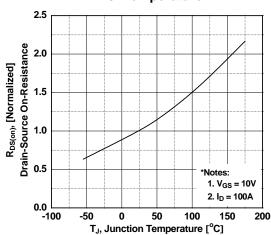


Figure 10. Maximum Drain Current

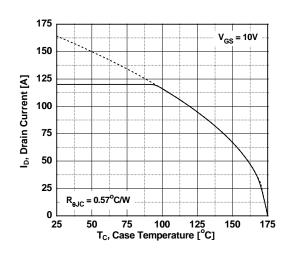
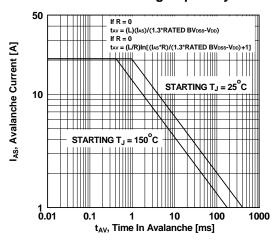
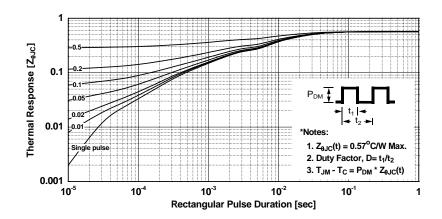


Figure 12. Unclamped Inductive Switching Capability

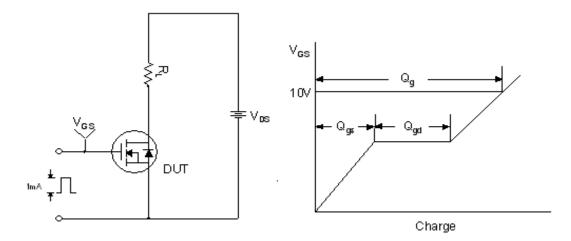


Typical Performance Characteristics (Continued)

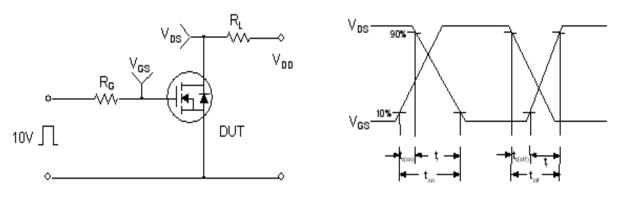
Figure 13. Transient Thermal Response Curve



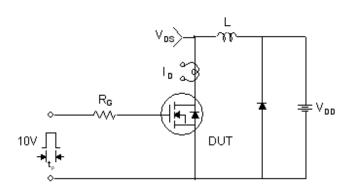
Gate Charge Test Circuit & Waveform

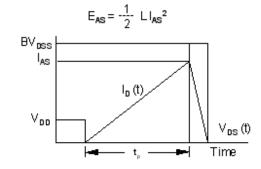


Resistive Switching Test Circuit & Waveforms

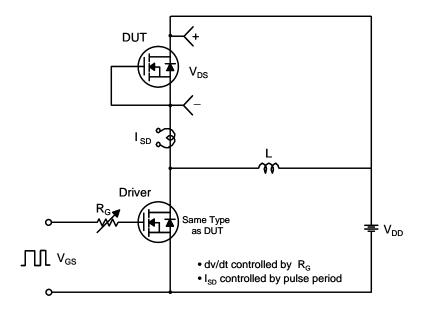


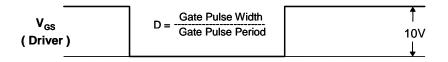
Unclamped Inductive Switching Test Circuit & Waveforms

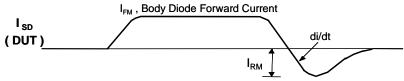




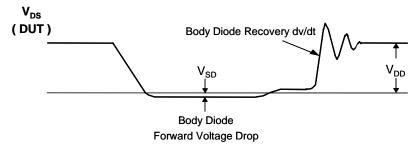
Peak Diode Recovery dv/dt Test Circuit & Waveforms





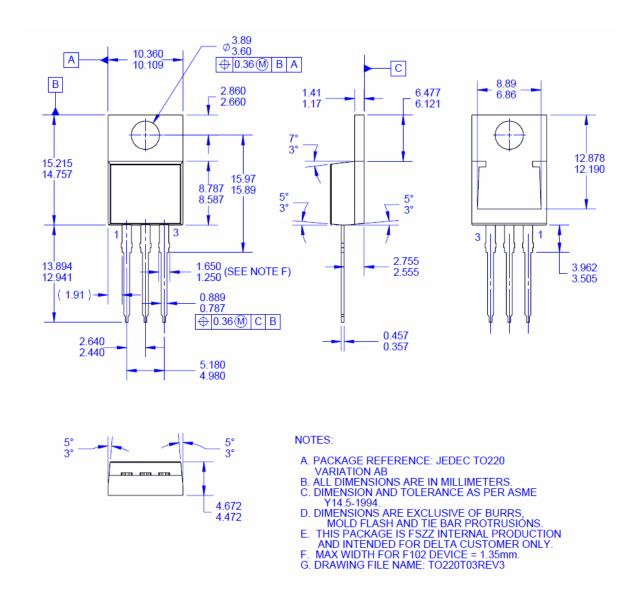


Body Diode Reverse Current



Mechanical Dimensions

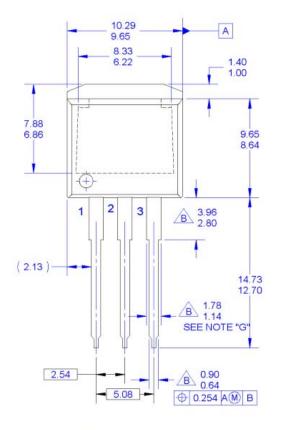
TO-220

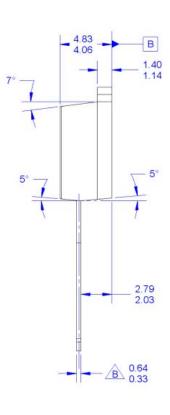


Dimensions in Millimeters

Package Dimensions

I2PAK





NOTES:

- A EXCEPT WHERE NOTED CONFORMS TO TO262 JEDEC VARIATION AA.

 B DOES NOT COMPLY JEDEC STD. VALUE.
 C. ALL DIMENSIONS ARE IN MILLIMETERS.
 D. DIMENSIONS ARE EXCLUSIVE OF BURRS.
 MOLD FLASH AND TIE BAR PROTRUSIONS.
 E. DIMENSION AND TOLERANCE AS PER ANSI Y14.5-1994.
 F. LOCATION OF PIN HOLE MAY VARY
 (LOWER LEFT CORNER, LOWER CENTER AND CENTER OF PACKAGE)
 G. MAXIMUM WIDTH FOR F102 DEVICE = 1.35 MAX.
 H. DRAWING FILE NAME: TO262A03REV5





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